Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SON, HEE-KWAN | Examiner | Art Unit | Devin Almeida | 2132 | Page 1 of 1

'U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,668,267	12-2003	Pomet, Alain	708/492
*	В	US-6,438,569	08-2002	Abbott, Curtis	708/603
*	С	US-5,790,874	08-1998	Takano et al.	713/320
	D	US-			
	E	US-			, .
	F	US-			
	G	US-			·
	Н	US-	,		
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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<u> </u>		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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*A copy of this reference is not being furnished with this O ffice action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classif ications may be US or foreign.